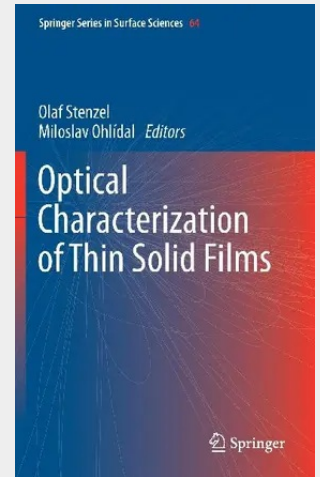


Optical Characterization of Thin Solid Films

This book is an up-to-date survey of the major optical characterization techniques for thin solid films. Emphasis is placed on practicability of the various approaches. Relevant fundamentals are briefly reviewed before demonstrating the application of these techniques to practically relevant research and development topics. The book is written by international top experts, all of whom are involved in industrial research and development projects.

Offers a sophisticated synthesis of fundamental and applied topics and a didactic presentation Excellent interconnectedness of chapters through authors' belonging to collaborating working groups Written by international top experts involved in industrial research and development



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